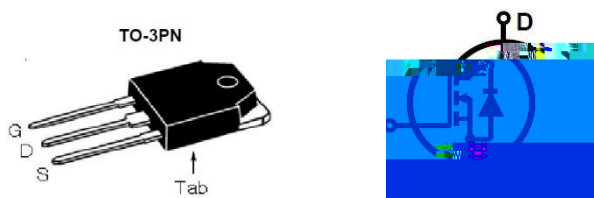


N-channel MOSFET

Features

- Low gate charge
- 100% avalanche tested
- Improved dv/dt capability
- RoHS compliant
- JEDEC Qualification

BV_{DSS}	I_D	$R_{DS(on)}$
600V	16A	< 0.47



Device	Package	Marking	Remark
TMAN16N60	TO-3PN	TMAN16N60	RoHS

Absolute Maximum Ratings

Parameter	Symbol	TMAN16N60	Unit
Drain-Source Voltage	V_{DS}	600	V
Gate-Source Voltage	V_{GS}	30	V
Continuous Drain Current	I_D	$T_C = 25$	16
		$T_C = 100$	10.3
Pulsed Drain Current ^(Note 1)	I_{DM}	64	A
Single Pulse Avalanche Energy ^(Note 2)	E_{AS}	865	mJ
Repetitive Avalanche Current ^(Note 1)	I_{AR}	16	A
Repetitive Avalanche Energy ^(Note 1)	E_{AR}	31.2	mJ
Power Dissipation	P_D	$T_C = 25$	312
		Derate above 25	2.5
Peak Diode Recovery dv/dt ^(Note 3)	dv/dt	4.5	V/ns
Operating Junction and Storage Temperature Range	T_J, T_{STG}	-55~150	
Maximum lead temperature for soldering purposes, 1/8" from case for 5 seconds	T_L	300	

* Limited only by maximum junction temperature

Thermal Characteristics

Parameter	Symbol	TMAN16N60	Unit
Maximum Thermal resistance, Junction-to-Case	R_{JC}	0.4	/W
Maximum Thermal resistance, Junction-to-Ambient	R_{JA}	62.5	/W

Electrical Characteristics : $T_C=25$, unless otherwise noted

Parameter	Symbol	Test condition	Min	Typ	Max	Units
OFF						
Drain-Source Breakdown Voltage	BV_{DSS}	$V_{GS} = 0\text{ V}, I_D = 250\ \mu\text{A}$	600	--	--	V
Zero Gate Voltage Drain Current	I_{DSS}	$V_{DS} = 600\text{ V}, V_{GS} = 0\text{ V}$	--	--	4	μA
		$V_{DS} = 480\text{ V}, T_C = 125\text{ }^\circ\text{C}$	--	--	10	μA
Forward Gate-Source Leakage Current	I_{GSSF}	$V_{GS} = 30\text{ V}, V_{DS} = 0\text{ V}$	--	--	100	nA
Reverse Gate-Source Leakage Current	I_{GSSR}	$V_{GS} = -30\text{ V}, V_{DS} = 0\text{ V}$	--	--	-100	nA

ON

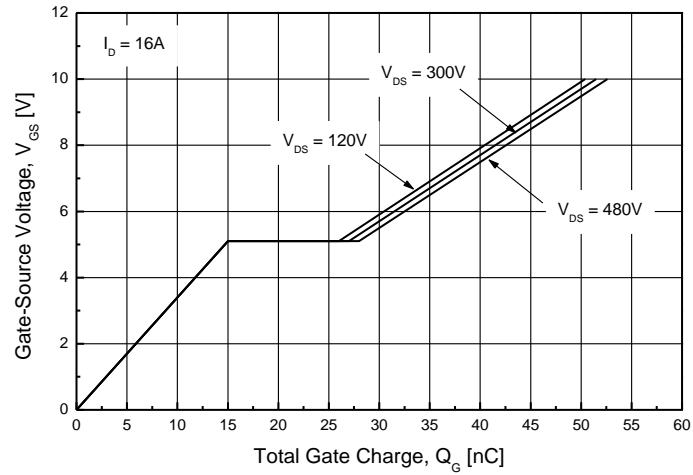
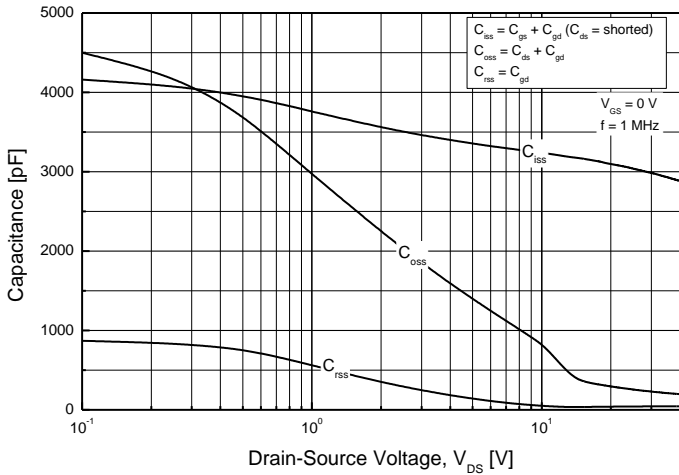
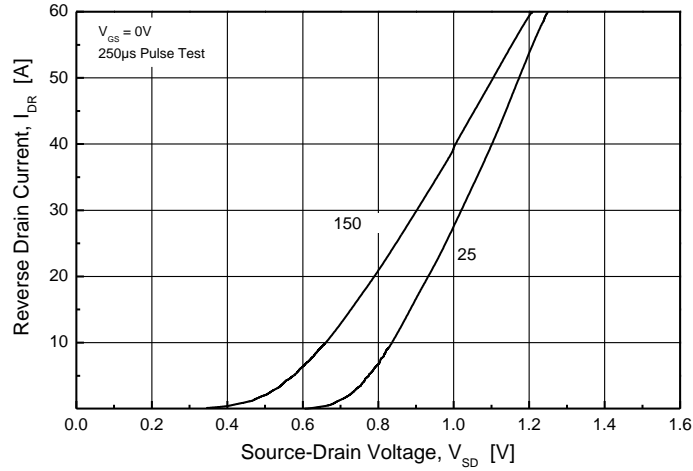
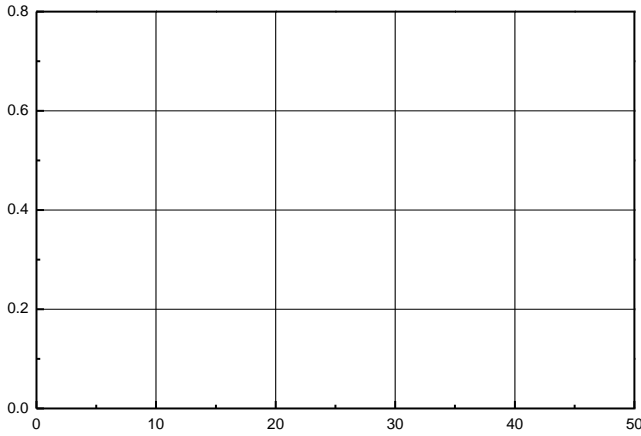
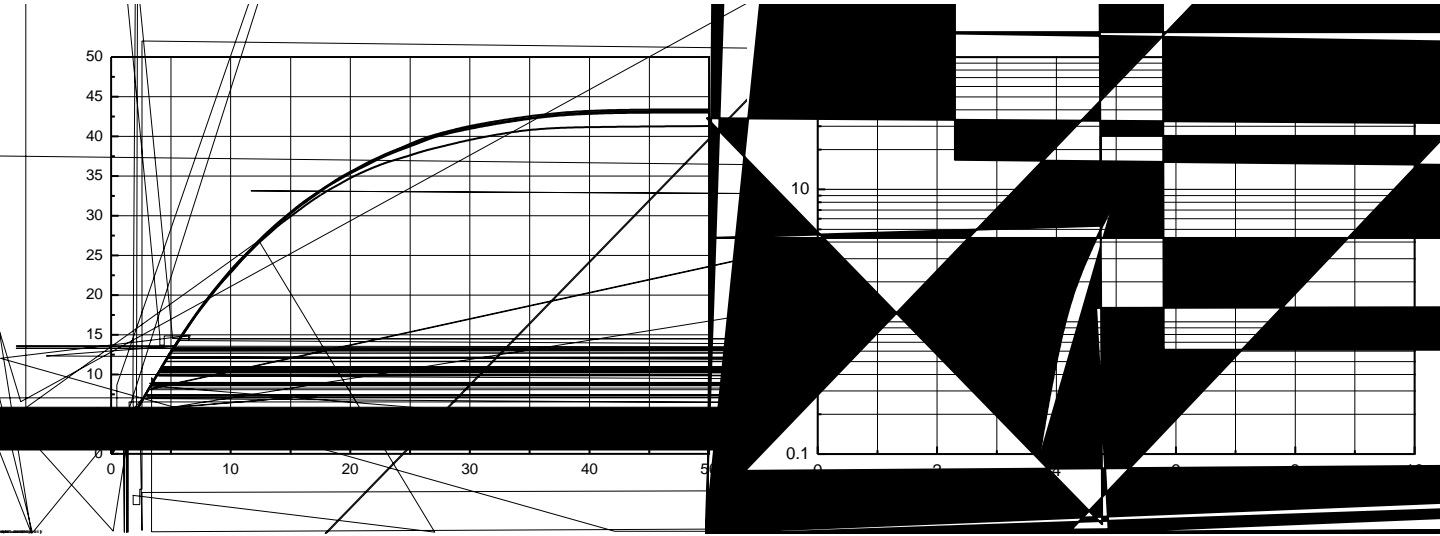
Gate Threshold Voltage	$V_{GS(th)}$	$V_{DS} = V_{GS}, I_D = 250\ \mu\text{A}$	2	--	4	V
Drain-Source On-Resistance	$R_{DS(on)}$	$V_{GS} = 10\text{ V}, I_D = 8\text{ A}$	--	0.38	0.47	
Forward Transconductance ^(Note 4)	g_{FS}	$V_{DS} = 30\text{ V}, I_{DS} = 8\text{ A}$	--	10	--	S

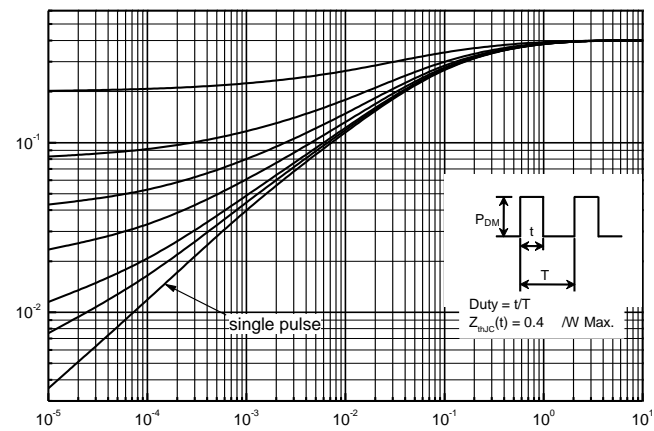
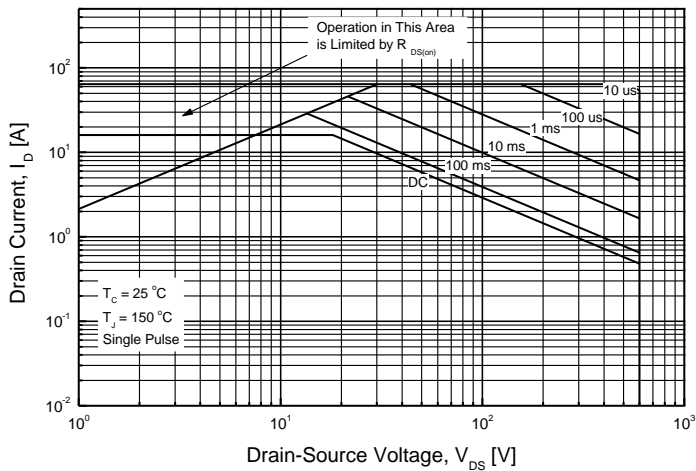
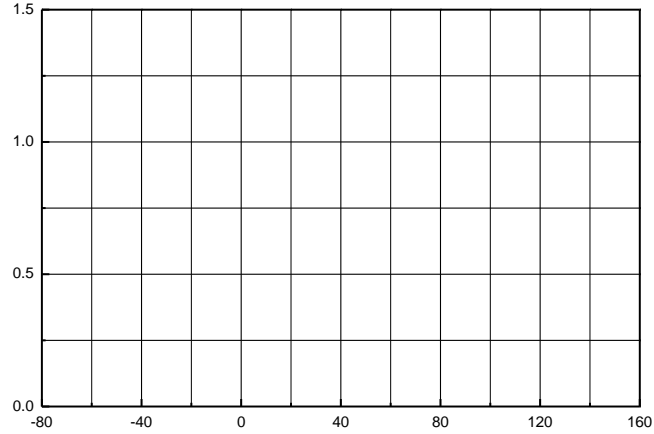
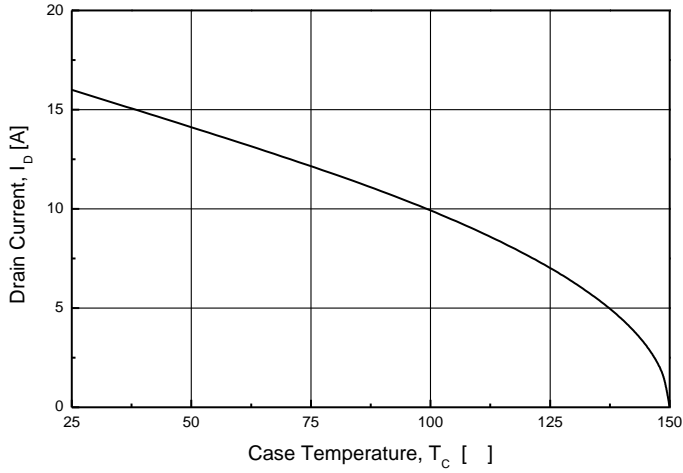
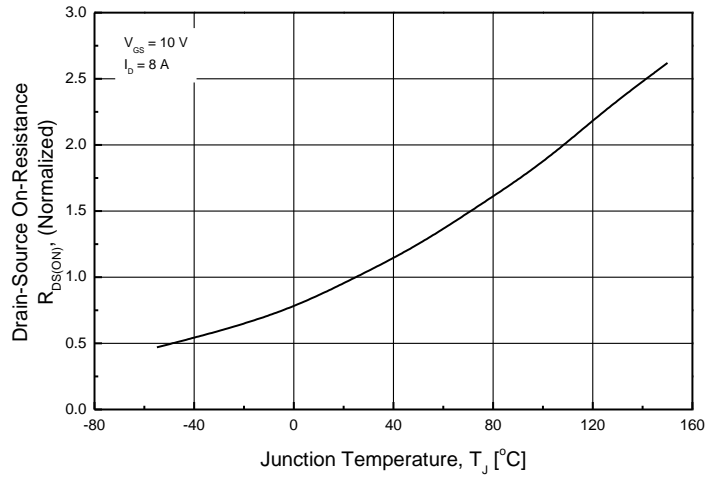
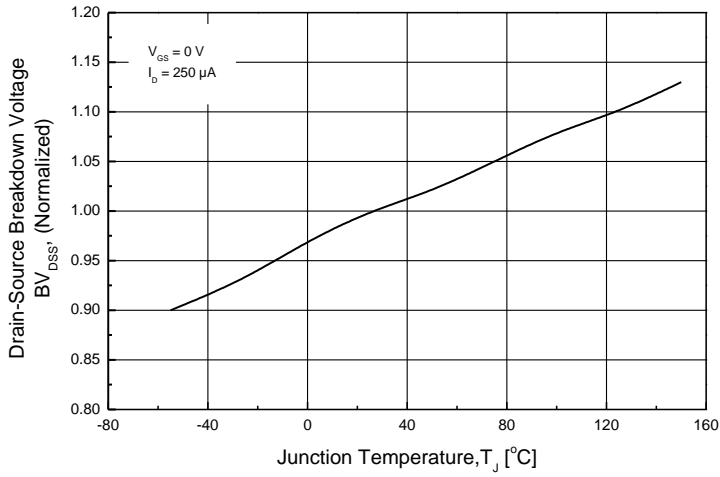
DYNAMIC

Input Capacitance	C_{iss}	$V_{GS} = 25\text{ V}, V_{DS} = 0\text{ V}$	224.47	224.47	224.47	pF
Output Capacitance	C_{oss}	$V_{GS} = 0\text{ V}, V_{DS} = 600\text{ V}$	110.23	110.23	110.23	pF
Reverse Transfer Capacitance	C_{rss}	$V_{GS} = 25\text{ V}, V_{DS} = 600\text{ V}$	11.02	11.02	11.02	pF

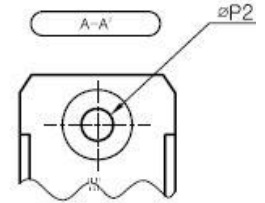
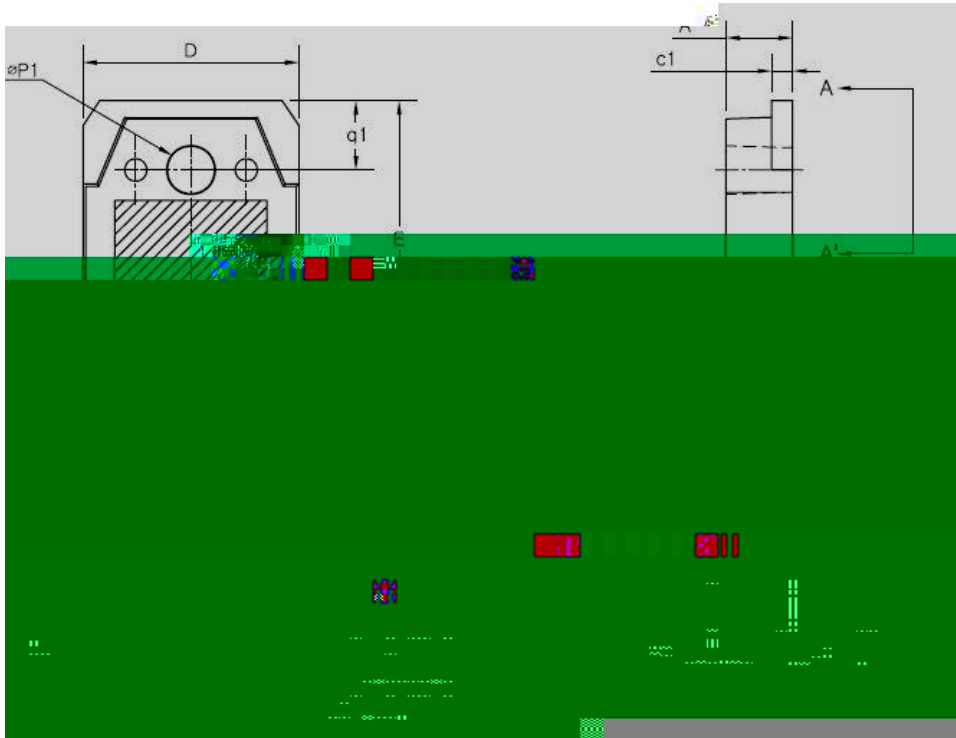
Note :

1. Repeated rating : Pulse width limited by safe operating area
2. $L=6.2\text{mH}, I_{AS} = 16\text{A}, V_{DD} = 50\text{V}, R_G = 25$, Starting $T_J = 25$, not subject to production test – verified by design/characterization
3. $I_{SD} = 16\text{A}, di/dt = 200\text{A}/\mu\text{s}, V_{DD} = BV_{DS},$ Starting $T_J = 25$
4. Pulse Test :Pulse width 300 μs , Duty Cycle 2%
5. Essentially Independent of Operating Temperature Typical Characteristics





TO-3PN MECHANICAL DATA



SYMBOL	MIN	NOM	MAX
A	4.60	4.80	5.00
b	0.80	1.00	1.20
b1	1.80	2.00	2.20
b2	2.80	3.00	3.20
c	0.55	0.60	0.75
c1	1.45	1.50	1.65
D	15.40	15.60	15.80
E	19.70	19.90	20.10
e	5.15	5.45	5.75
L1	3.30	3.50	3.70
L2	19.80	20.00	20.20
øP1	3.30	3.40	3.50
øP2	3.20	3.20	3.20
Q	2.20	2.40	2.60
q1	4.80	5.00	5.20

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